

Notice of References Cited

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Applicant(s)/Patent Under
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Examiner
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Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-Pub. US-2004/0196	10-2004	Shimizu	345/3.1
	B	US-2004/0196550			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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